



## Dielectric Probe Calibration Report

Ref : ACR.49.20.22.BES.A

**BTF TESTING LAB (SHENZHEN) CO., LTD.**  
**F101,201 AND 301, BUILDING 1, BLOCK 2, TANTOU**  
**INDUSTRIAL PARK, TANTOU COMMUNITY**  
**SONGGANG STREET, BAO'AN DISTRICT, SHENZHEN,**  
**CHINA**

**MVG LIMESAR DIELECTRIC PROBE**

**FREQUENCY: 0.4-6 GHZ**

**SERIAL NO.: SN 06/22 OCPG 88**

**Calibrated at MVG**

**Z.I. de la pointe du diable**

**Technopôle Brest Iroise – 295 avenue Alexis de Rochon**

**29280 PLOUZANE - FRANCE**

**Calibration date: 02/02/2024**



Accreditations #2-6789  
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### *Summary:*

This document presents the method and results from an accredited Dielectric Probe calibration performed at MVG, using the LIMESAR test bench. The test results covered by accreditation are traceable to the International System of Units (SI).



|                      | <i>Name</i>  | <i>Function</i>     | <i>Date</i> | <i>Signature</i> |
|----------------------|--------------|---------------------|-------------|------------------|
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|                       | <i>Customer Name</i>                       |
|-----------------------|--------------------------------------------|
| <i>Distribution :</i> | BTF Testing Lab<br>(Shenzhen) Co.,<br>Ltd. |

| <i>Issue</i> | <i>Name</i> | <i>Date</i> | <i>Modifications</i> |
|--------------|-------------|-------------|----------------------|
| A            | Jérôme Luc  | 2/2/2024    | Initial release      |
|              |             |             |                      |
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